

Spectroscopy of trivalent neodymium ions (Nd3+) in zinc oxide (ZnO) powders and thin films



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1. INTRODUCTION AND MOTIVATION Trivalent rare-earth (RE³⁺) doped ZnO

- Wide-band-gap semiconductor with wurtzite structure.
- Energy gap of 3.4 eV at 4 K and high melting temperature (2248 K) hence regarded as a strong material.
- Most reported emission from ZnO:Nd³⁺ was obtained with UV excitation at room temperature (300 K). [1]

Research Aim

 Spectroscopic study of Nd³⁺ ions in ZnO powders and thin films using VIS excitation at 10 K.

2. EXPERIMENTAL **Laser Spectroscopy**



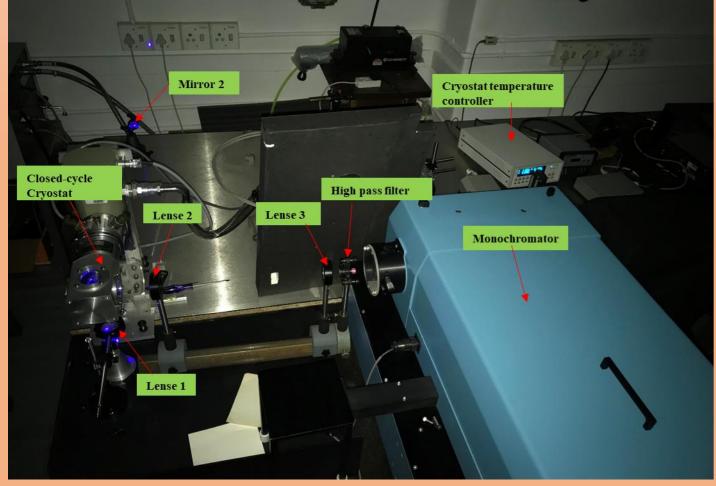


Figure 1: Setup for fluorescence spectroscopy measurements

3. THEORY

- ZnO has intrinsic point defects namely: vacancies (Vo and V_{Zn}), interstitials (O_i and Zn_i) and antisites (O_{Zn} and Zn_O). [2]
- Both the extrinsic and intrinsic defects affect the optical behaviour of ZnO.
- Rare-earth extrinsic defects enhance the photoluminescence properties of ZnO.
- Spectroscopy is a non-destructive method for studying the photoluminescence properties of doped materials.[3]
- Transitions between the intrinsic defect levels are broad while the rare-earth transitions are narrow and discreet.

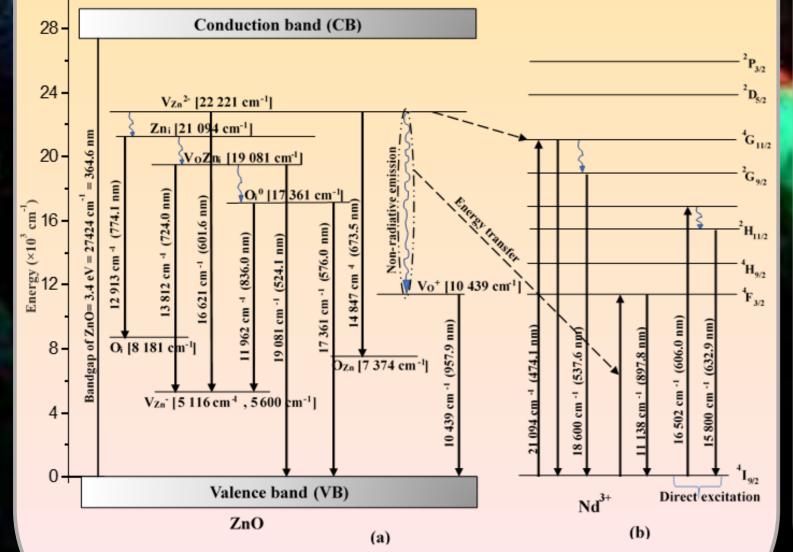


Figure 2: (a) Some defects states which lie within the bandgap of ZnO and (b) energy states of Nd3+ ions.

RESULTS AND DISCUSSION Fluorescence from ZnO intrinsic defects

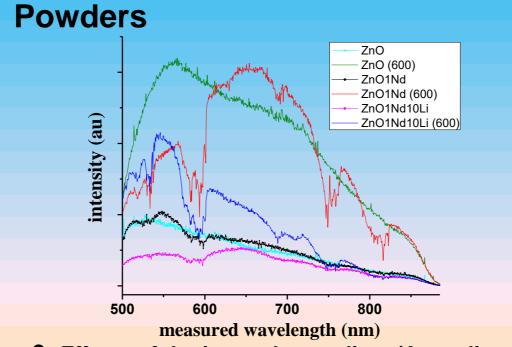


Figure 3: Effects of doping and annealing. (Annealing: 600 °C; air; 2 hrs; RMP = 5 °C/min).

- Reabsorption features in the broad ZnO emission profile indicate energy transfer between the extrinsic and ZnO intrinsic defects.
- The positions of the reabsorption features match the energy levels of Nd3+ ions.
- Decrease in the intrinsic defects emission after codoping ZnO:Nd3+ with Li+ and annealing indicates redistribution of the intrinsic defects.

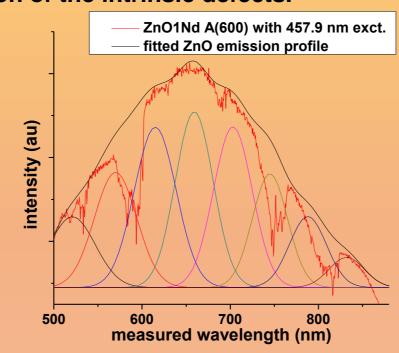


Figure 4: Gaussian fitting on the defects emission

Thin Films

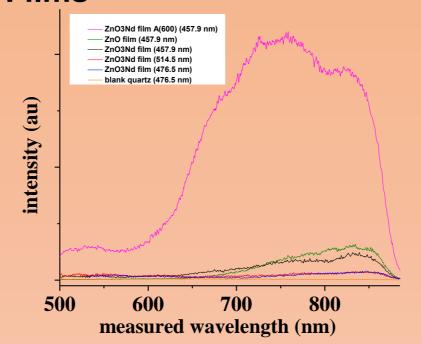


Figure 5: Effects of doping, annealing and varying the excitation wavelength. (Annealing: 600 °C; air; 2 hrs; RMP = 5 °C/min).

- Same emission profile with different excitation wavelengths with highest intensity from highest excitation energy (457.9 nm)
- Annealing improved emission peaks at 639 nm, 678 nm, 722 nm and 767 nm due to introduced oxygen defects

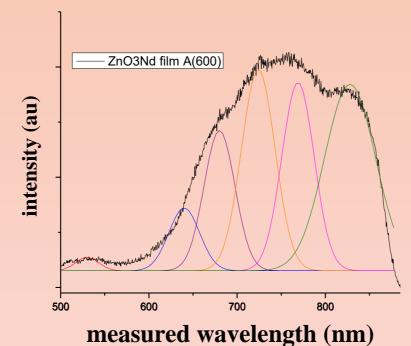


Figure 6: Gaussian fitting of defects emission

The Gaussian peak positions for the powders and the films are given in Table 1 with the corresponding transitions as illustrated in Figure 2 (a)

Table 1 Peak positions and transitions

4.2 Fluorescence from Nd³⁺ extrinsic defects in ZnO

a. Powders

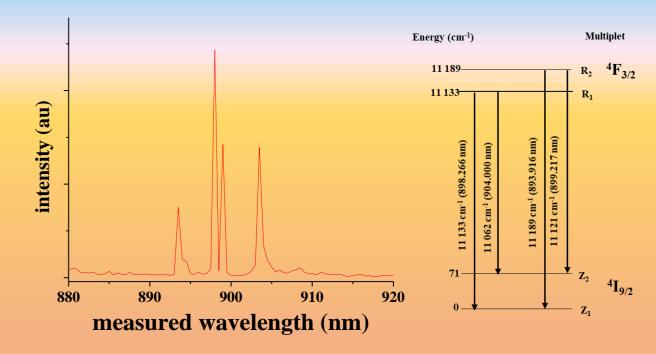


Figure 7: Emission and energy level scheme.

- Co-doping with Li+ ions and annealing at 950 °C encourages the existence of V_o+ defects which are linked to the population of the ${}^4F_{3/2}$ multiplet.
- Channels for energy transfer from the intrinsic to extrinsic defects are shown in Figure 2.

b. Thin Films

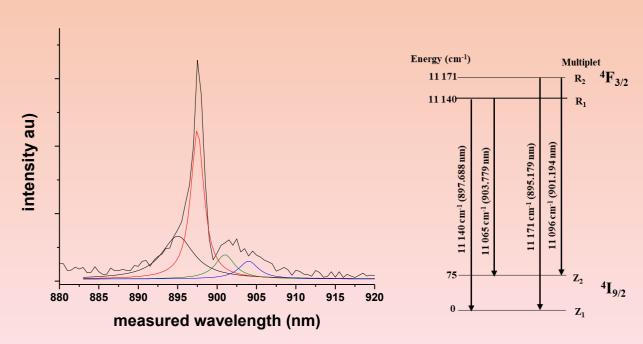


Figure 8: Emission and the corresponding energy level scheme

5. CONCLUSION

- several Nd³⁺-reabsorption features are observed in the region from 500 nm to 850 nm, emission is only observable from ~ 900 nm (from the ⁴F_{3/2} multiplet).
- The energy level positions of Nd³⁺ ions are similar in the films and the powders; the broader film transitions could be an indication of the quality of the films.

Applications

- ✓ NIR emission: bio-imaging, NIR lasers and colored-light emission.
- ✓ Reabsorption: absorbing the yellow-flame glow on welder's goggles
- ✓ Doped sintered-powders: cost-effective targets for thin film deposition by the pulsed laser technique.

6. WORK IN PROGRESS

- **Structural characterization**
 - Direct excitation of Nd³⁺ ions (Figure 2 (b)) using dye lasers.

7. REFERENCES

- [1] Balestrieri, M. et al. J. Mater. Chem. C 2, 9182–9188 (2014).
- [2] Janotti, A. and Van De Walle, C. G. (2009) Fundamentals of zinc oxide as a semiconductor', Reports on Progress in Physics, 72(12).
- [3] Garc´ıa Sol´e, J., et.al. (2005) An Introduction to the Optical Spectroscopy. England: John Wiley & Sons Ltd.

8. ACKNOWLEDGEMENTS

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